Synchrotrons have revolutionized powder diffraction. They enable the rapid collection of high quality powder diffraction patterns with tremendous resolution and superb signal to noise. In addition, the high penetration and exceptional data sensitivity possible at high-energy light sources, like the Advanced Photon Source (APS), allow exploration of trace containment levels, in-situ sample environments and crystallographic site occupancies which previously demanded neutron sources. Despite all these advantages, relatively few scientists today consider using a synchrotron for their powder diffraction studies. To address this, the high resolution synchrotron powder diffractometer beamline 11-BM at the APS offers rapid and easy mail-in access for routine structural analyses with truly world-class quality data\textsuperscript{1}. This instrument offers world-class resolution and sensitivity and is a free service for non-proprietary users\textsuperscript{2}. The instrument can collect a superb pattern suitable for Rietveld analysis in less than an hour, is equipped with a robotic arm for automated sample changes, and features variable temperature sample environments. Users of the mail-in program typically receive their high-resolution data within two weeks of sample receipt. The diffractometer is also available for on-site experiments requiring more specialized measurements.

This presentation will describe this instrument, highlight its capabilities, explain the types of measurements currently available, as well as recent significant improvements to the instrument’s performance. We will discuss plans to improve access and the available sample environments and collection protocols. We are particularly interested in seeking input from potential users within the powder diffraction community.

More information about the 11-BM diffractometer and its associated mail-in program can be found at our website: https://11bm.xray.aps.anl.gov.